

Notice of References Cited	Application/Control No. 09/989,390	Applicant(s)/Patent Under Reexamination OHKI, MASAHIKO	
	Examiner Mark Eashoo, Ph.D.	Art Unit 1732	Page 1 of 1

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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